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Understanding **Embedded - FPGAs (Field Programmable Gate Array)**

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications,

Details

| | |
|--------------------------------|---|
| Product Status | Active |
| Number of LABs/CLBs | 5831 |
| Number of Logic Elements/Cells | 74637 |
| Total RAM Bits | 3170304 |
| Number of I/O | 328 |
| Number of Gates | - |
| Voltage - Supply | 1.14V ~ 1.26V |
| Mounting Type | Surface Mount |
| Operating Temperature | -40°C ~ 100°C (TJ) |
| Package / Case | 484-FBGA, CSPBGA |
| Supplier Device Package | 484-CSPBGA (19x19) |
| Purchase URL | https://www.e-xfl.com/product-detail/xilinx/xc6slx75-3csg484i |

Table 3: eFUSE Programming Conditions⁽¹⁾

| Symbol | Description | Min | Typ | Max | Units |
|------------------|--|------|------|------|--------------------|
| $V_{FS}^{(2)}$ | External voltage supply | 3.2 | 3.3 | 3.4 | V |
| I_{FS} | V_{FS} supply current | – | – | 40 | mA |
| V_{CCAUX} | Auxiliary supply voltage relative to GND | 3.2 | 3.3 | 3.45 | V |
| $R_{FUSE}^{(3)}$ | External resistor from R_{FUSE} pin to GND | 1129 | 1140 | 1151 | Ω |
| V_{CCINT} | Internal supply voltage relative to GND | 1.14 | 1.2 | 1.26 | V |
| t_j | Temperature range | 15 | – | 85 | $^{\circ}\text{C}$ |

Notes:

1. These specifications apply during programming of the eFUSE AES key. Programming is only supported through JTAG. The AES key is only supported in the following devices: LX75, LX75T, LX100, LX100T, LX150, and LX150T.
2. When programming eFUSE, V_{FS} must be less than or equal to V_{CCAUX} . When not programming or when eFUSE is not used, Xilinx recommends connecting V_{FS} to GND. However, V_{FS} can be between GND and 3.45 V.
3. An R_{FUSE} resistor is required when programming the eFUSE AES key. When not programming or when eFUSE is not used, Xilinx recommends connecting the R_{FUSE} pin to V_{CCAUX} or GND. However, R_{FUSE} can be unconnected.

Quiescent Current

Typical values for quiescent supply current are specified at nominal voltage, 25°C junction temperatures (T_j). Quiescent supply current is specified by speed grade for Spartan-6 devices. Xilinx recommends analyzing static power consumption using the XPOWER™ Estimator (XPE) tool (download at <http://www.xilinx.com/power>) for conditions other than those specified in Table 5.

Table 5: Typical Quiescent Supply Current

| Symbol | Description | Device | Speed Grade | | | | Units |
|---------------------|---|--------|-------------|------|------|------|-------|
| | | | -3 | -3N | -2 | -1L | |
| I _{CCINTQ} | Quiescent V _{CCINT} supply current | LX4 | 4.0 | 4.0 | 4.0 | 2.4 | mA |
| | | LX9 | 4.0 | 4.0 | 4.0 | 2.4 | mA |
| | | LX16 | 6.0 | 6.0 | 6.0 | 4.0 | mA |
| | | LX25 | 11.0 | 11.0 | 11.0 | 6.6 | mA |
| | | LX25T | 11.0 | 11.0 | 11.0 | N/A | mA |
| | | LX45 | 15.0 | 15.0 | 15.0 | 9.0 | mA |
| | | LX45T | 15.0 | 15.0 | 15.0 | N/A | mA |
| | | LX75 | 29.0 | 29.0 | 29.0 | 17.4 | mA |
| | | LX75T | 29.0 | 29.0 | 29.0 | N/A | mA |
| | | LX100 | 36.0 | 36.0 | 36.0 | 21.6 | mA |
| | | LX100T | 36.0 | 36.0 | 36.0 | N/A | mA |
| | | LX150 | 51.0 | 51.0 | 51.0 | 31.0 | mA |
| | | LX150T | 51.0 | 51.0 | 51.0 | N/A | mA |
| I _{CCOQ} | Quiescent V _{CCO} supply current | LX4 | 1.0 | 1.0 | 1.0 | 1.0 | mA |
| | | LX9 | 1.0 | 1.0 | 1.0 | 1.0 | mA |
| | | LX16 | 2.0 | 2.0 | 2.0 | 2.0 | mA |
| | | LX25 | 2.0 | 2.0 | 2.0 | 2.0 | mA |
| | | LX25T | 2.0 | 2.0 | 2.0 | N/A | mA |
| | | LX45 | 3.0 | 3.0 | 3.0 | 3.0 | mA |
| | | LX45T | 3.0 | 3.0 | 3.0 | N/A | mA |
| | | LX75 | 4.0 | 4.0 | 4.0 | 4.0 | mA |
| | | LX75T | 4.0 | 4.0 | 4.0 | N/A | mA |
| | | LX100 | 5.0 | 5.0 | 5.0 | 5.0 | mA |
| | | LX100T | 5.0 | 5.0 | 5.0 | N/A | mA |
| | | LX150 | 7.0 | 7.0 | 7.0 | 7.0 | mA |
| | | LX150T | 7.0 | 7.0 | 7.0 | N/A | mA |

Table 5: Typical Quiescent Supply Current (Cont'd)

| Symbol | Description | Device | Speed Grade | | | | Units |
|---------------------|---|--------|-------------|------|------|------|-------|
| | | | -3 | -3N | -2 | -1L | |
| I _{CCAUXQ} | Quiescent V _{CCAUX} supply current | LX4 | 2.5 | 2.5 | 2.5 | 2.5 | mA |
| | | LX9 | 2.5 | 2.5 | 2.5 | 2.5 | mA |
| | | LX16 | 3.0 | 3.0 | 3.0 | 3.0 | mA |
| | | LX25 | 4.0 | 4.0 | 4.0 | 4.0 | mA |
| | | LX25T | 4.0 | 4.0 | 4.0 | N/A | mA |
| | | LX45 | 5.0 | 5.0 | 5.0 | 5.0 | mA |
| | | LX45T | 5.0 | 5.0 | 5.0 | N/A | mA |
| | | LX75 | 7.0 | 7.0 | 7.0 | 7.0 | mA |
| | | LX75T | 7.0 | 7.0 | 7.0 | N/A | mA |
| | | LX100 | 9.0 | 9.0 | 9.0 | 9.0 | mA |
| | | LX100T | 9.0 | 9.0 | 9.0 | N/A | mA |
| | | LX150 | 12.0 | 12.0 | 12.0 | 12.0 | mA |
| | | LX150T | 12.0 | 12.0 | 12.0 | N/A | mA |

Notes:

1. Typical values are specified at nominal voltage, 25°C junction temperatures (T_j). Industrial (I) grade devices have the same typical values as commercial (C) grade devices at 25°C, but higher values at 100°C. Use the XPE tool to calculate 100°C values. Nominal V_{CCINT} is 1.20V; use the XPE tool to calculate 1.23V values for the nominal V_{CCINT} of the extended performance range.
2. Typical values are for blank configured devices with no output current loads, no active input pull-up resistors, all I/O pins are 3-state and floating.
3. If differential signaling is used, more accurate quiescent current estimates can be obtained by using the XPOWER Estimator (XPE) or XPOWER Analyzer (XPA) tools.

Table 6: Power Supply Ramp Time

| Symbol | Description | Speed Grade | Ramp Time | Units |
|----------------------------------|--|-------------|--------------|-------|
| V _{CCINTR} | Internal supply voltage ramp time | -3, -3N, -2 | 0.20 to 50.0 | ms |
| | | -1L | 0.20 to 40.0 | ms |
| V _{CCO2} ⁽¹⁾ | Output drivers bank 2 supply voltage ramp time | All | 0.20 to 50.0 | ms |
| V _{CCAUXR} | Auxiliary supply voltage ramp time | All | 0.20 to 50.0 | ms |

Notes:

1. The minimum V_{CCO2} for power-on reset and configuration is 1.65V.
2. Spartan-6 FPGAs require a certain amount of supply current during power-on to insure proper device initialization. The actual current consumed depends on the power-on ramp rate of the power supply. Use the XPOWER Estimator (XPE) or XPOWER Analyzer (XPA) tools to estimate current drain on these supplies. Spartan-6 devices do not have a required power-on sequence.

SelectIO™ Interface DC Input and Output Levels

Table 7: Recommended Operating Conditions for User I/Os Using Single-Ended Standards

| I/O Standard | V _{CCO} for Drivers ⁽¹⁾ | | | V _{REF} for Inputs | | |
|------------------------|---|--------|--------|--|--------|--------|
| | V, Min | V, Nom | V, Max | V, Min | V, Nom | V, Max |
| LVTTTL | 3.0 | 3.3 | 3.45 | V _{REF} is not used for these I/O standards | | |
| LVC MOS33 | 3.0 | 3.3 | 3.45 | | | |
| LVC MOS25 | 2.3 | 2.5 | 2.7 | | | |
| LVC MOS18 | 1.65 | 1.8 | 1.95 | | | |
| LVC MOS18_JEDEC | 1.65 | 1.8 | 1.95 | | | |
| LVC MOS15 | 1.4 | 1.5 | 1.6 | | | |
| LVC MOS15_JEDEC | 1.4 | 1.5 | 1.6 | | | |
| LVC MOS12 | 1.1 | 1.2 | 1.3 | | | |
| LVC MOS12_JEDEC | 1.1 | 1.2 | 1.3 | | | |
| PCI33_3 ⁽²⁾ | 3.0 | 3.3 | 3.45 | | | |
| PCI66_3 ⁽²⁾ | 3.0 | 3.3 | 3.45 | | | |
| I2C | 2.7 | 3.0 | 3.45 | | | |
| SMBUS | 2.7 | 3.0 | 3.45 | | | |
| SDIO | 3.0 | 3.3 | 3.45 | | | |
| MOBILE_DDR | 1.7 | 1.8 | 1.9 | | | |
| HSTL_I | 1.4 | 1.5 | 1.6 | 0.68 | 0.75 | 0.9 |
| HSTL_II | 1.4 | 1.5 | 1.6 | 0.68 | 0.75 | 0.9 |
| HSTL_III | 1.4 | 1.5 | 1.6 | – | 0.9 | – |
| HSTL_I_18 | 1.7 | 1.8 | 1.9 | 0.8 | 0.9 | 1.1 |
| HSTL_II_18 | 1.7 | 1.8 | 1.9 | – | 0.9 | – |
| HSTL_III_18 | 1.7 | 1.8 | 1.9 | – | 1.1 | – |
| SSTL3_I | 3.0 | 3.3 | 3.45 | 1.3 | 1.5 | 1.7 |
| SSTL3_II | 3.0 | 3.3 | 3.45 | 1.3 | 1.5 | 1.7 |
| SSTL2_I | 2.3 | 2.5 | 2.7 | 1.13 | 1.25 | 1.38 |
| SSTL2_II | 2.3 | 2.5 | 2.7 | 1.13 | 1.25 | 1.38 |
| SSTL18_I | 1.7 | 1.8 | 1.9 | 0.833 | 0.9 | 0.969 |
| SSTL18_II | 1.7 | 1.8 | 1.9 | 0.833 | 0.9 | 0.969 |
| SSTL15_II | 1.425 | 1.5 | 1.575 | 0.69 | 0.75 | 0.81 |

Notes:

1. V_{CCO} range required when using I/O standard for an output. Also required for MOBILE_DDR, PCI33_3, LVC MOS18_JEDEC, LVC MOS15_JEDEC, and LVC MOS12_JEDEC inputs, and for LVC MOS25 inputs when V_{CCAUX} = 3.3V.
2. For PCI systems, the transmitter and receiver should have common supplies for V_{CCO}.

Table 10: Differential I/O Standard DC Input and Output Levels

| I/O Standard | V _{ID} | | V _{ICM} | | V _{OD} | | V _{OCM} | | V _{OH} | V _{OL} |
|-----------------------------|-----------------|---------|------------------|---------------------|-----------------|---------|------------------------------|--------------------------|------------------------|------------------------|
| | mV, Min | mV, Max | V, Min | V, Max | mV, Min | mV, Max | V, Min | V, Max | V, Min | V, Max |
| LVDS_33 ⁽²⁾⁽³⁾ | 100 | 600 | 0.3 | 2.35 | 247 | 454 | 1.125 | 1.375 | – | – |
| LVDS_25 ⁽²⁾⁽³⁾ | 100 | 600 | 0.3 | 2.35 | 247 | 454 | 1.125 | 1.375 | – | – |
| BLVDS_25 ⁽²⁾⁽³⁾ | 100 | – | 0.3 | 2.35 | 240 | 460 | Typical 50% V _{CCO} | | – | – |
| MINI_LVDS_33 | 200 | 600 | 0.3 | 1.95 | 300 | 600 | 1.0 | 1.4 | – | – |
| MINI_LVDS_25 | 200 | 600 | 0.3 | 1.95 | 300 | 600 | 1.0 | 1.4 | – | – |
| LVPECL_33 ⁽²⁾⁽³⁾ | 100 | 1000 | 0.3 | 2.8 ⁽¹⁾ | Inputs only | | | | | |
| LVPECL_25 ⁽²⁾⁽³⁾ | 100 | 1000 | 0.3 | 1.95 | Inputs only | | | | | |
| RSDS_33 ⁽²⁾⁽³⁾ | 100 | – | 0.3 | 1.5 | 100 | 400 | 1.0 | 1.4 | – | – |
| RSDS_25 ⁽²⁾⁽³⁾ | 100 | – | 0.3 | 1.5 | 100 | 400 | 1.0 | 1.4 | – | – |
| TMDS_33 | 150 | 1200 | 2.7 | 3.23 ⁽¹⁾ | 400 | 800 | V _{CCO} – 0.405 | V _{CCO} – 0.190 | – | – |
| PPDS_33 ⁽²⁾⁽³⁾ | 100 | 400 | 0.2 | 2.3 | 100 | 400 | 0.5 | 1.4 | – | – |
| PPDS_25 ⁽²⁾⁽³⁾ | 100 | 400 | 0.2 | 2.3 | 100 | 400 | 0.5 | 1.4 | – | – |
| DISPLAY_PORT | 190 | 1260 | 0.3 | 2.35 | – | – | Typical 50% V _{CCO} | | – | – |
| DIFF_MOBILE_DDR | 100 | – | 0.78 | 1.02 | – | – | – | – | 90% V _{CCO} | 10% V _{CCO} |
| DIFF_HSTL_I | 100 | – | 0.68 | 0.9 | – | – | – | – | V _{CCO} – 0.4 | 0.4 |
| DIFF_HSTL_II | 100 | – | 0.68 | 0.9 | – | – | – | – | V _{CCO} – 0.4 | 0.4 |
| DIFF_HSTL_III | 100 | – | 0.68 | 0.9 | – | – | – | – | V _{CCO} – 0.4 | 0.4 |
| DIFF_HSTL_I_18 | 100 | – | 0.8 | 1.1 | – | – | – | – | V _{CCO} – 0.4 | 0.4 |
| DIFF_HSTL_II_18 | 100 | – | 0.8 | 1.1 | – | – | – | – | V _{CCO} – 0.4 | 0.4 |
| DIFF_HSTL_III_18 | 100 | – | 0.8 | 1.1 | – | – | – | – | V _{CCO} – 0.4 | 0.4 |
| DIFF_SSTL3_I | 100 | – | 1.0 | 1.9 | – | – | – | – | V _{TT} + 0.6 | V _{TT} – 0.6 |
| DIFF_SSTL3_II | 100 | – | 1.0 | 1.9 | – | – | – | – | V _{TT} + 0.8 | V _{TT} – 0.8 |
| DIFF_SSTL2_I | 100 | – | 1.0 | 1.5 | – | – | – | – | V _{TT} + 0.61 | V _{TT} – 0.61 |
| DIFF_SSTL2_II | 100 | – | 1.0 | 1.5 | – | – | – | – | V _{TT} + 0.81 | V _{TT} – 0.81 |
| DIFF_SSTL18_I | 100 | – | 0.7 | 1.1 | – | – | – | – | V _{TT} + 0.47 | V _{TT} – 0.47 |
| DIFF_SSTL18_II | 100 | – | 0.7 | 1.1 | – | – | – | – | V _{TT} + 0.6 | V _{TT} – 0.6 |
| DIFF_SSTL15_II | 100 | – | 0.55 | 0.95 | – | – | – | – | V _{TT} + 0.4 | V _{TT} – 0.4 |

Notes:

1. LVPECL_33 and TMDS_33 maximum V_{ICM} is the lower of V (maximum) or V_{CCAUX} – (V_{ID}/2)
2. When V_{CCAUX} = 3.3V, the DCD can be higher than 5% for V_{ICM} < 0.7V when using these I/O standards: LVDS_25, LVDS_33, BLVDS_25, LVPECL_25, LVPECL_33, RSDS_25, RSDS_33, PPDS_25, and PPDS_33.
3. The -1L devices require V_{CCAUX} = 2.5V when using the LVDS_25, LVDS_33, BLVDS_25, LVPECL_25, RSDS_25, RSDS_33, PPDS_25, and PPDS_33 I/O standards on inputs. LVPECL_33 is not supported in the -1L devices.

eFUSE Read Endurance

Table 11 lists the minimum guaranteed number of read cycle operations for Device DNA and for the AES eFUSE key. For more information, see [UG380: Spartan-6 FPGA Configuration User Guide](#).

Table 11: eFUSE Read Endurance

| Symbol | Description | Speed Grade | | | | Units (Min) |
|------------|---|-------------|-----|----|-----|-------------|
| | | -3 | -3N | -2 | -1L | |
| DNA_CYCLES | Number of DNA_PORT READ operations or JTAG ISC_DNA read command operations. Unaffected by SHIFT operations. | 30,000,000 | | | | Read Cycles |
| AES_CYCLES | Number of JTAG FUSE_KEY or FUSE_CNTL read command operations. Unaffected by SHIFT operations. | 30,000,000 | | | | Read Cycles |

GTP Transceiver Specifications

GTP transceivers are available in the Spartan-6 LXT devices. See [DS160: Spartan-6 Family Overview](#) for more information.

GTP Transceiver DC Characteristics

Table 12: Absolute Maximum Ratings for GTP Transceivers⁽¹⁾

| Symbol | Description | Min | Max | Units |
|------------------------|--|------|------|-------|
| MGTAVCC | Analog supply voltage for the GTP transmitter and receiver circuits relative to GND | -0.5 | 1.32 | V |
| MGTAVTTTX | Analog supply voltage for the GTP transmitter termination circuit relative to GND | -0.5 | 1.32 | V |
| MGTAVTTRX | Analog supply voltage for the GTP receiver termination circuit relative to GND | -0.5 | 1.32 | V |
| MGTAVCCPLL | Analog supply voltage for the GTP transmitter and receiver PLL circuits relative to GND | -0.5 | 1.32 | V |
| MGTAVTTRCAL | Analog supply voltage for the resistor calibration circuit of the GTP transceiver bank (top or bottom) | -0.5 | 1.32 | V |
| V _{IN} | Receiver (RXP/RXN) and Transmitter (TXP/TXN) absolute input voltage | -0.5 | 1.32 | V |
| V _{MGTREFCLK} | Reference clock absolute input voltage | -0.5 | 1.32 | V |

Notes:

- Stresses beyond those listed under Absolute Maximum Ratings might cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those listed under Operating Conditions is not implied. Exposure to Absolute Maximum Ratings conditions for extended periods of time might affect device reliability.

Table 13: Recommended Operating Conditions for GTP Transceivers⁽¹⁾⁽²⁾⁽³⁾

| Symbol | Description | Min | Typ | Max | Units |
|-------------|--|------|------|------|-------|
| MGTAVCC | Analog supply voltage for the GTP transmitter and receiver circuits relative to GND | 1.14 | 1.20 | 1.26 | V |
| MGTAVTTTX | Analog supply voltage for the GTP transmitter termination circuit relative to GND | 1.14 | 1.20 | 1.26 | V |
| MGTAVTTRX | Analog supply voltage for the GTP receiver termination circuit relative to GND | 1.14 | 1.20 | 1.26 | V |
| MGTAVCCPLL | Analog supply voltage for the GTP transmitter and receiver PLL circuits relative to GND | 1.14 | 1.20 | 1.26 | V |
| MGTAVTTRCAL | Analog supply voltage for the resistor calibration circuit of the GTP transceiver bank (top or bottom) | 1.14 | 1.20 | 1.26 | V |

Notes:

- Each voltage listed requires the filter circuit described in [UG386: Spartan-6 FPGA GTP Transceivers User Guide](#).
- Voltages are specified for the temperature range of T_j = -40°C to +125°C.
- The voltage level of MGTAVCCPLL must not exceed the voltage level of MGTAVCC +10mV. The voltage level of MGTAVCC must not exceed the voltage level of MGTAVCCPLL.

Performance Characteristics

This section provides the performance characteristics of some common functions and designs implemented in Spartan-6 devices. The numbers reported here are worst-case values; they have all been fully characterized. These values are subject to the same guidelines as the [Switching Characteristics, page 19](#).

Table 25: Interface Performances

| Description | I/O Resource | Clock Buffer | Data Width | Speed Grade | | | | Units |
|---|--------------------------|--------------|------------|-------------|------------------------|-----|-----|-------|
| | | | | -3 | -3N | -2 | -1L | |
| Networking Applications⁽¹⁾ | | | | | | | | |
| SDR LVDS transmitter or receiver | IOB SDR register | BUFG | – | 400 | 400 | 375 | 250 | Mb/s |
| DDR LVDS transmitter or receiver | ODDR2/IDDR2 register | 2 BUFGs | – | 800 | 800 | 750 | 500 | Mb/s |
| SDR LVDS transmitter | OSERDES2 | BUFPLL | 2 | 500 | 500 | 500 | 250 | Mb/s |
| | | | 3 | 750 | 750 | 750 | 375 | Mb/s |
| | | | 4-8 | 1080 | 1050 | 950 | 500 | Mb/s |
| DDR LVDS transmitter | OSERDES2 | 2 BUFIO2s | 2 | 500 | 500 | 500 | 250 | Mb/s |
| | | | 3 | 750 | 750 | 750 | 375 | Mb/s |
| | | | 4-8 | 1080 | 1050 | 950 | 500 | Mb/s |
| SDR LVDS receiver | ISERDES2 in RETIMED mode | BUFPLL | 2 | 500 | 500 | 500 | — | Mb/s |
| | | | 3 | 750 | 750 | 750 | — | Mb/s |
| | | | 4-8 | 1080 | 1050 | 950 | — | Mb/s |
| DDR LVDS receiver | ISERDES2 in RETIMED mode | 2 BUFIO2s | 2 | 500 | 500 | 500 | — | Mb/s |
| | | | 3 | 750 | 750 | 750 | — | Mb/s |
| | | | 4-8 | 1080 | 1050 | 950 | — | Mb/s |
| Memory Interfaces (Implemented using the Spartan-6 FPGA Memory Controller Block)⁽²⁾ | | | | | | | | |
| Standard Performance (Standard V_{CCINT}) | | | | | | | | |
| DDR | | | | 400 | Note 4 | 400 | 350 | Mb/s |
| DDR2 | | | | 667 | Note 4 | 625 | 400 | Mb/s |
| DDR3 | | | | 800 | Note 4 | 667 | — | Mb/s |
| LPDDR (Mobile_DDR) | | | | 400 | Note 4 | 400 | 350 | Mb/s |
| Extended Performance (Requires Extended Performance V_{CCINT})⁽³⁾ | | | | | | | | |
| DDR2 | | | | 800 | Note 4 | 667 | — | Mb/s |

Notes:

1. Refer to [XAPP1064](#), *Source-Synchronous Serialization and Deserialization (up to 1050 Mb/s)* and [UG381](#), *Spartan-6 FPGA SelectIO Resources User Guide*.
2. Refer to [UG388](#), *Spartan-6 FPGA Memory Controller User Guide*.
3. Extended Memory Controller block performance for DDR2 can be achieved using the extended performance V_{CCINT} range from [Table 2](#).
4. The LX4 device, all devices in the TQG144 and CPG196 packages, and the -3N speed grade do not support a Memory Controller Block.

Production Silicon and ISE Software Status

In some cases, a particular family member (and speed grade) is released to production before a speed specification is released with the correct label (Advance, Preliminary, Production). Any labeling discrepancies are corrected in subsequent speed specification releases. [Table 27](#) lists the production released Spartan-6 family member, speed grade, and the minimum corresponding supported speed specification version and ISE® software revisions. The ISE software and speed specifications listed are the minimum releases required for production. All subsequent releases of software and speed specifications are valid.

Table 27: Spartan-6 Device Production Software and Speed Specification Release⁽¹⁾

| Device | Speed Grade Designations ⁽²⁾ | | | |
|------------|---|--------------------------------------|-------------------------------|----------------|
| | -3 ⁽³⁾ | -3N | -2 ⁽⁴⁾ | -1L |
| XC6SLX4 | ISE 12.4 v1.15 | N/A | ISE 12.3 v1.12 ⁽⁵⁾ | ISE 13.2 v1.07 |
| XC6SLX9 | ISE 12.4 v1.15 | ISE 13.1 Update v1.18 ⁽⁷⁾ | ISE 12.3 v1.12 ⁽⁵⁾ | ISE 13.2 v1.07 |
| XC6SLX16 | ISE 12.1 v1.08 | ISE 13.1 Update v1.18 ⁽⁷⁾ | ISE 11.5 v1.06 | ISE 13.2 v1.07 |
| XC6SLX25 | ISE 12.2 v1.11 ⁽⁶⁾ | ISE 13.1 Update v1.18 ⁽⁷⁾ | ISE 12.2 v1.11 ⁽⁶⁾ | ISE 13.2 v1.07 |
| XC6SLX25T | ISE 12.2 v1.11 ⁽⁶⁾ | ISE 13.1 Update v1.18 ⁽⁷⁾ | ISE 12.2 v1.11 ⁽⁶⁾ | N/A |
| XC6SLX45 | ISE 12.1 v1.08 | ISE 13.1 Update v1.18 ⁽⁷⁾ | ISE 11.5 v1.07 | ISE 13.1 v1.06 |
| XC6SLX45T | ISE 12.1 v1.08 | ISE 13.1 Update v1.18 ⁽⁷⁾ | ISE 12.1 v1.08 | N/A |
| XC6SLX75 | ISE 12.2 v1.11 ⁽⁶⁾ | ISE 13.1 Update v1.18 ⁽⁷⁾ | ISE 12.2 v1.11 ⁽⁶⁾ | ISE 13.2 v1.07 |
| XC6SLX75T | ISE 12.2 v1.11 ⁽⁶⁾ | ISE 13.1 Update v1.18 ⁽⁷⁾ | ISE 12.2 v1.11 ⁽⁶⁾ | N/A |
| XC6SLX100 | ISE 12.2 v1.11 ⁽⁶⁾ | ISE 13.1 Update v1.18 ⁽⁷⁾ | ISE 12.2 v1.11 ⁽⁶⁾ | ISE 13.1 v1.06 |
| XC6SLX100T | ISE 12.2 v1.11 ⁽⁶⁾ | ISE 13.1 Update v1.18 ⁽⁷⁾ | ISE 12.2 v1.11 ⁽⁶⁾ | N/A |
| XC6SLX150 | ISE 12.2 v1.11 ⁽⁶⁾ | ISE 13.1 Update v1.18 ⁽⁷⁾ | ISE 12.2 v1.11 ⁽⁶⁾ | ISE 13.1 v1.06 |
| XC6SLX150T | ISE 12.2 v1.11 ⁽⁶⁾ | ISE 13.1 Update v1.18 ⁽⁷⁾ | ISE 12.2 v1.11 ⁽⁶⁾ | N/A |
| XA6SLX4 | ISE 13.2 v1.19 | N/A | ISE 13.2 v1.19 | N/A |
| XA6SLX9 | ISE 13.2 v1.19 | N/A | ISE 13.2 v1.19 | N/A |
| XA6SLX16 | ISE 13.2 v1.19 | N/A | ISE 13.2 v1.19 | N/A |
| XA6SLX25 | ISE 13.2 v1.19 | N/A | ISE 13.2 v1.19 | N/A |
| XA6SLX25T | ISE 13.2 v1.19 | N/A | ISE 13.2 v1.19 | N/A |
| XA6SLX45 | ISE 13.2 v1.19 | N/A | ISE 13.2 v1.19 | N/A |
| XA6SLX45T | ISE 13.2 v1.19 | N/A | ISE 13.2 v1.19 | N/A |
| XA6SLX75 | ISE 13.2 v1.19 | N/A | ISE 13.2 v1.19 | N/A |
| XA6SLX75T | ISE 13.2 v1.19 | N/A | ISE 13.2 v1.19 | N/A |
| XA6SLX100 | N/A | N/A | ISE 13.3 v1.20 | N/A |

Table 27: Spartan-6 Device Production Software and Speed Specification Release⁽¹⁾ (Cont'd)

| Device | Speed Grade Designations ⁽²⁾ | | | |
|------------|---|-----|-------------------|----------------|
| | -3 ⁽³⁾ | -3N | -2 ⁽⁴⁾ | -1L |
| XQ6SLX75 | N/A | N/A | ISE 13.2 v1.19 | ISE 13.2 v1.07 |
| XQ6SLX75T | ISE 13.2 v1.19 | N/A | ISE 13.2 v1.19 | N/A |
| XQ6SLX150 | N/A | N/A | ISE 13.2 v1.19 | ISE 13.2 v1.07 |
| XQ6SLX150T | ISE 13.2 v1.19 | N/A | ISE 13.2 v1.19 | N/A |

Notes:

1. ISE 13.3 software with v1.20 for -3, -3N, and -2; and v1.08 for -1L speed specification reflects the changes outlined in [XCN11028: Spartan-6 FPGA Speed File Changes](#).
2. As marked with an N/A, LXT devices and all XA devices are not available with a -1L speed grade; LX4 devices and all XA and XQ devices are not available with a -3N speed grade.
3. Improved -3 specifications reflected in this data sheet require ISE 12.4 software with v1.15 speed specification.
4. Improved -2 specifications reflected in this data sheet require ISE 12.4 software and the *12.4 Speed Files Patch* which contains the v1.17 speed specification available on the [Xilinx Download Center](#).
5. ISE 12.3 software with v1.12 speed specification is available using ISE 12.3 software and the *12.3 Speed Files Patch* available on the [Xilinx Download Center](#).
6. ISE 12.2 software with v1.11 speed specification is available using ISE 12.2 software and the *12.2 Speed Files Patch* available on the [Xilinx Download Center](#).
7. ISE 13.1 software with v1.18 speed specification is available using ISE 13.1 software and the *13.1 Update* available on the [Xilinx Download Center](#). See [XCN11012: Speed File Change for -3N Devices](#).

IOB Pad Input/Output/3-State Switching Characteristics

Table 28 (for commercial (XC) Spartan-6 devices) and Table 29 (for Automotive XA Spartan-6 and Defense-grade Spartan-6Q devices) summarizes the values of standard-specific data input delays, output delays terminating at pads (based on standard), and 3-state delays.

- T_{IOPI} is described as the delay from IOB pad through the input buffer to the I-pin of an IOB pad. The delay varies depending on the capability of the SelectIO input buffer.
- T_{IOOP} is described as the delay from the O pin to the IOB pad through the output buffer of an IOB pad. The delay varies depending on the capability of the SelectIO output buffer.
- T_{IOTP} is described as the delay from the T pin to the IOB pad through the output buffer of an IOB pad, when 3-state is disabled. The delay varies depending on the SelectIO capability of the output buffer.

See the TRACE report for further information on delays when using an I/O standard with UNTUNED termination on inputs or outputs.

Table 28: IOB Switching Characteristics for the Commercial (XC) Spartan-6 Devices

| I/O Standard | T_{IOPI} | | | | T_{IOOP} | | | | T_{IOTP} | | | | Units |
|--------------------------|-------------|------|------|--------------------|-------------|------|------|--------------------|-------------|------|------|--------------------|-------|
| | Speed Grade | | | | Speed Grade | | | | Speed Grade | | | | |
| | -3 | -3N | -2 | -1L ⁽¹⁾ | -3 | -3N | -2 | -1L ⁽¹⁾ | -3 | -3N | -2 | -1L ⁽¹⁾ | |
| LVDS_33 | 1.17 | 1.29 | 1.42 | 1.68 | 1.55 | 1.69 | 1.89 | 2.42 | 3000 | 3000 | 3000 | 3000 | ns |
| LVDS_25 | 1.01 | 1.13 | 1.26 | 1.57 | 1.65 | 1.79 | 1.99 | 2.47 | 3000 | 3000 | 3000 | 3000 | ns |
| BLVDS_25 | 1.02 | 1.14 | 1.27 | 1.57 | 1.72 | 1.86 | 2.06 | 2.68 | 1.72 | 1.86 | 2.06 | 2.68 | ns |
| MINI_LVDS_33 | 1.17 | 1.29 | 1.42 | 1.68 | 1.57 | 1.71 | 1.91 | 2.41 | 3000 | 3000 | 3000 | 3000 | ns |
| MINI_LVDS_25 | 1.01 | 1.13 | 1.26 | 1.57 | 1.65 | 1.79 | 1.99 | 2.47 | 3000 | 3000 | 3000 | 3000 | ns |
| LVPECL_33 | 1.18 | 1.30 | 1.43 | 1.68 | N/A | N/A | N/A | N/A | N/A | N/A | N/A | N/A | ns |
| LVPECL_25 | 1.02 | 1.14 | 1.27 | 1.57 | N/A | N/A | N/A | N/A | N/A | N/A | N/A | N/A | ns |
| RSDS_33 (point to point) | 1.17 | 1.29 | 1.42 | 1.68 | 1.57 | 1.71 | 1.91 | 2.42 | 3000 | 3000 | 3000 | 3000 | ns |
| RSDS_25 (point to point) | 1.01 | 1.13 | 1.26 | 1.56 | 1.65 | 1.79 | 1.99 | 2.47 | 3000 | 3000 | 3000 | 3000 | ns |
| TMDS_33 | 1.21 | 1.33 | 1.46 | 1.71 | 1.54 | 1.68 | 1.88 | 2.50 | 3000 | 3000 | 3000 | 3000 | ns |

Table 29: IOB Switching Characteristics for the Automotive XA Spartan-6 and the Spartan-6Q Devices⁽¹⁾ (Cont'd)

| I/O Standard | T _{IOPI} | | T _{IOOP} | | T _{IOTP} | | Units |
|---------------------------|-------------------|------|-------------------|------|-------------------|------|-------|
| | Speed Grade | | Speed Grade | | Speed Grade | | |
| | -3 | -2 | -3 | -2 | -3 | -2 | |
| DIFF_SSTL3_I | 1.26 | 1.44 | 1.95 | 2.15 | 1.95 | 2.15 | ns |
| DIFF_SSTL3_II | 1.26 | 1.44 | 1.94 | 2.14 | 1.94 | 2.14 | ns |
| DIFF_SSTL2_I | 1.09 | 1.27 | 1.94 | 2.14 | 1.94 | 2.14 | ns |
| DIFF_SSTL2_II | 1.09 | 1.27 | 1.90 | 2.10 | 1.90 | 2.10 | ns |
| DIFF_SSTL18_I | 1.04 | 1.22 | 1.86 | 2.06 | 1.86 | 2.06 | ns |
| DIFF_SSTL18_II | 1.05 | 1.23 | 1.82 | 2.02 | 1.82 | 2.02 | ns |
| DIFF_SSTL15_II | 1.01 | 1.19 | 1.81 | 2.01 | 1.81 | 2.01 | ns |
| DIFF_MOBILE_DDR | 1.04 | 1.22 | 1.89 | 2.09 | 1.89 | 2.09 | ns |
| LVTTL, QUIETIO, 2 mA | 1.42 | 1.60 | 5.64 | 5.84 | 5.64 | 5.84 | ns |
| LVTTL, QUIETIO, 4 mA | 1.42 | 1.60 | 4.46 | 4.66 | 4.46 | 4.66 | ns |
| LVTTL, QUIETIO, 6 mA | 1.42 | 1.60 | 3.92 | 4.12 | 3.92 | 4.12 | ns |
| LVTTL, QUIETIO, 8 mA | 1.42 | 1.60 | 3.37 | 3.57 | 3.37 | 3.57 | ns |
| LVTTL, QUIETIO, 12 mA | 1.42 | 1.60 | 3.42 | 3.62 | 3.42 | 3.62 | ns |
| LVTTL, QUIETIO, 16 mA | 1.42 | 1.60 | 3.09 | 3.29 | 3.09 | 3.29 | ns |
| LVTTL, QUIETIO, 24 mA | 1.42 | 1.60 | 2.83 | 3.03 | 2.83 | 3.03 | ns |
| LVTTL, Slow, 2 mA | 1.42 | 1.60 | 4.58 | 4.78 | 4.58 | 4.78 | ns |
| LVTTL, Slow, 4 mA | 1.42 | 1.60 | 3.38 | 3.58 | 3.38 | 3.58 | ns |
| LVTTL, Slow, 6 mA | 1.42 | 1.60 | 2.95 | 3.15 | 2.95 | 3.15 | ns |
| LVTTL, Slow, 8 mA | 1.42 | 1.60 | 2.73 | 2.93 | 2.73 | 2.93 | ns |
| LVTTL, Slow, 12 mA | 1.42 | 1.60 | 2.72 | 2.92 | 2.72 | 2.92 | ns |
| LVTTL, Slow, 16 mA | 1.42 | 1.60 | 2.53 | 2.73 | 2.53 | 2.73 | ns |
| LVTTL, Slow, 24 mA | 1.42 | 1.60 | 2.42 | 2.62 | 2.42 | 2.62 | ns |
| LVTTL, Fast, 2 mA | 1.42 | 1.60 | 4.04 | 4.24 | 4.04 | 4.24 | ns |
| LVTTL, Fast, 4 mA | 1.42 | 1.60 | 2.66 | 2.86 | 2.66 | 2.86 | ns |
| LVTTL, Fast, 6 mA | 1.42 | 1.60 | 2.58 | 2.78 | 2.58 | 2.78 | ns |
| LVTTL, Fast, 8 mA | 1.42 | 1.60 | 2.46 | 2.66 | 2.46 | 2.66 | ns |
| LVTTL, Fast, 12 mA | 1.42 | 1.60 | 1.97 | 2.17 | 1.97 | 2.17 | ns |
| LVTTL, Fast, 16 mA | 1.42 | 1.60 | 1.97 | 2.17 | 1.97 | 2.17 | ns |
| LVTTL, Fast, 24 mA | 1.42 | 1.60 | 1.97 | 2.17 | 1.97 | 2.17 | ns |
| LVC MOS33, QUIETIO, 2 mA | 1.41 | 1.59 | 5.65 | 5.85 | 5.65 | 5.85 | ns |
| LVC MOS33, QUIETIO, 4 mA | 1.41 | 1.59 | 4.20 | 4.40 | 4.20 | 4.40 | ns |
| LVC MOS33, QUIETIO, 6 mA | 1.41 | 1.59 | 3.65 | 3.85 | 3.65 | 3.85 | ns |
| LVC MOS33, QUIETIO, 8 mA | 1.41 | 1.59 | 3.51 | 3.71 | 3.51 | 3.71 | ns |
| LVC MOS33, QUIETIO, 12 mA | 1.41 | 1.59 | 3.09 | 3.29 | 3.09 | 3.29 | ns |
| LVC MOS33, QUIETIO, 16 mA | 1.41 | 1.59 | 2.91 | 3.11 | 2.91 | 3.11 | ns |
| LVC MOS33, QUIETIO, 24 mA | 1.41 | 1.59 | 2.73 | 2.93 | 2.73 | 2.93 | ns |
| LVC MOS33, Slow, 2 mA | 1.41 | 1.59 | 4.59 | 4.79 | 4.59 | 4.79 | ns |
| LVC MOS33, Slow, 4 mA | 1.41 | 1.59 | 3.14 | 3.34 | 3.14 | 3.34 | ns |

Table 33: Spartan-6 FPGA V_{CCO}/GND Pairs per Bank

| Package | Devices | Description | Bank 0 | Bank 1 | Bank 2 | Bank 3 | Bank 4 | Bank 5 |
|----------|--------------------|-----------------------------|--------|--------|--------|--------|--------|--------|
| TQG144 | LX | V _{CCO} /GND Pairs | 3 | 3 | 2 | 3 | N/A | N/A |
| | | Maximum I/O per Pair | 8 | 8 | 13 | 8 | N/A | N/A |
| CPG196 | LX | V _{CCO} /GND Pairs | 4 | 6 | 4 | 6 | N/A | N/A |
| | | Maximum I/O per Pair | 6 | 4 | 7 | 4 | N/A | N/A |
| CSG225 | LX | V _{CCO} /GND Pairs | 4 | 4 | 4 | 4 | N/A | N/A |
| | | Maximum I/O per Pair | 10 | 10 | 9 | 10 | N/A | N/A |
| FT(G)256 | LX | V _{CCO} /GND Pairs | 5 | 6 | 4 | 5 | N/A | N/A |
| | | Maximum I/O per Pair | 8 | 9 | 9 | 10 | N/A | N/A |
| CSG324 | LX | V _{CCO} /GND Pairs | 6 | 6 | 6 | 6 | N/A | N/A |
| | | Maximum I/O per Pair | 10 | 9 | 10 | 9 | N/A | N/A |
| | LXT | V _{CCO} /GND Pairs | 4 | 6 | 6 | 6 | N/A | N/A |
| | | Maximum I/O per Pair | 4 | 9 | 10 | 9 | N/A | N/A |
| CS(G)484 | LX | V _{CCO} /GND Pairs | 8 | 13 | 8 | 13 | N/A | N/A |
| | | Maximum I/O per Pair | 7 | 8 | 7 | 8 | N/A | N/A |
| | LXT | V _{CCO} /GND Pairs | 7 | 12 | 8 | 13 | N/A | N/A |
| | | Maximum I/O per Pair | 5 | 8 | 6 | 8 | N/A | N/A |
| FG(G)484 | LX | V _{CCO} /GND Pairs | 10 | 10 | 11 | 11 | N/A | N/A |
| | | Maximum I/O per Pair | 6 | 8 | 9 | 8 | N/A | N/A |
| | LXT | V _{CCO} /GND Pairs | 6 | 10 | 11 | 10 | N/A | N/A |
| | | Maximum I/O per Pair | 7 | 8 | 7 | 8 | N/A | N/A |
| FG(G)676 | LX45 | V _{CCO} /GND Pairs | 12 | 15 | 10 | 16 | N/A | N/A |
| | | Maximum I/O per Pair | 3 | 7 | 8 | 7 | N/A | N/A |
| | LX75, LX100, LX150 | V _{CCO} /GND Pairs | 12 | 9 | 10 | 10 | 6 | 6 |
| | | Maximum I/O per Pair | 9 | 10 | 9 | 9 | 8 | 9 |
| | LXT | V _{CCO} /GND Pairs | 10 | 8 | 10 | 8 | 7 | 7 |
| | | Maximum I/O per Pair | 8 | 7 | 8 | 8 | 7 | 7 |
| FG(G)900 | LX | V _{CCO} /GND Pairs | 17 | 14 | 17 | 14 | 7 | 8 |
| | | Maximum I/O per Pair | 7 | 6 | 7 | 8 | 7 | 6 |
| | LXT | V _{CCO} /GND Pairs | 15 | 14 | 13 | 14 | 7 | 8 |
| | | Maximum I/O per Pair | 7 | 6 | 8 | 8 | 7 | 6 |

Input Serializer/Deserializer Switching Characteristics

Table 37: ISERDES2 Switching Characteristics

| Symbol | Description | Speed Grade | | | | Units |
|---|---|----------------|----------------|----------------|----------------|-------|
| | | -3 | -3N | -2 | -1L | |
| Setup/Hold for Control Lines | | | | | | |
| $T_{ISCK_BITSLIP} / T_{ISCKC_BITSLIP}$ | BITSLIP pin Setup/Hold with respect to CLKDIV | 0.16/ -0.09 | 0.20/ -0.09 | 0.31/ -0.09 | 0.34/ -0.14 | ns |
| $T_{ISCK_CE} / T_{ISCKC_CE}$ | CE pin Setup/Hold with respect to CLK | 0.71/ -0.47 | 0.71/ -0.42 | 0.97/ -0.42 | 1.39/ -0.71 | ns |
| Setup/Hold for Data Lines | | | | | | |
| $T_{ISDCK_D} / T_{ISCKD_D}$ | D pin Setup/Hold with respect to CLK | 0.24/ -0.15 | 0.25/ -0.05 | 0.29/ -0.05 | 0.09/ -0.05 | ns |
| $T_{ISDCK_DDL} / T_{ISCKD_DDL}$ | DDL pin Setup/Hold with respect to CLK (using IODELAY2) | -0.25/ 0.30 | -0.25/ 0.42 | -0.25/ 0.56 | -0.54/ 0.67 | ns |
| $T_{ISDCK_D_DDR} / T_{ISCKD_D_DDR}$ | D pin Setup/Hold with respect to CLK at DDR mode | -0.03/ 0.04 | -0.03/ 0.16 | -0.03/ 0.18 | -0.05/ 0.12 | ns |
| $T_{ISDCK_DDL_DDR} / T_{ISCKD_DDL_DDR}$ | D pin Setup/Hold with respect to CLK at DDR mode (using IODELAY2) | -0.40/ 0.48 | -0.40/ 0.53 | -0.40/ 0.71 | -0.71/ 0.86 | ns |
| Sequential Delays | | | | | | |
| T_{ISCKO_Q} | CLKDIV to out at Q pin | 1.30 | 1.44 | 2.02 | 2.22 | ns |
| F_{CLKDIV} | CLKDIV maximum frequency | 270 | 262.5 | 250 | 125 | MHz |

Output Serializer/Deserializer Switching Characteristics

Table 38: OSERDES2 Switching Characteristics

| Symbol | Description | Speed Grade | | | | Units |
|-------------------------------------|---|----------------|----------------|----------------|----------------|-------|
| | | -3 | -3N | -2 | -1L | |
| Setup/Hold | | | | | | |
| $T_{OSDCK_D} / T_{OSCKD_D}$ | D input Setup/Hold with respect to CLKDIV | -0.03/ 1.02 | -0.03/ 1.17 | -0.03/ 1.27 | -0.02/ 0.23 | ns |
| $T_{OSDCK_T} / T_{OSCKD_T}^{(1)}$ | T input Setup/Hold with respect to CLK | -0.05/ 1.03 | -0.05/ 1.13 | -0.05/ 1.23 | -0.05/ 0.24 | ns |
| $T_{OSCK_OCE} / T_{OSCKC_OCE}$ | OCE input Setup/Hold with respect to CLK | 0.12/ -0.03 | 0.15/ -0.03 | 0.24/ -0.03 | 0.28/ -0.17 | ns |
| $T_{OSCK_TCE} / T_{OSCKC_TCE}$ | TCE input Setup/Hold with respect to CLK | 0.14/ -0.08 | 0.17/ -0.08 | 0.27/ -0.08 | 0.31/ -0.16 | ns |
| Sequential Delays | | | | | | |
| T_{OSCKO_OQ} | Clock to out from CLK to OQ | 0.94 | 1.11 | 1.51 | 1.89 | ns |
| T_{OSCKO_TQ} | Clock to out from CLK to TQ | 0.94 | 1.11 | 1.51 | 1.91 | ns |
| F_{CLKDIV} | CLKDIV maximum frequency | 270 | 262.5 | 250 | 125 | MHz |

Notes:

- $T_{OSDCK_T2} / T_{OSCKD_T2}$ (T input setup/hold with respect to CLKDIV) are reported as $T_{OSDCK_T} / T_{OSCKD_T}$ in TRACE report.

DSP48A1 Switching Characteristics

Table 44: DSP48A1 Switching Characteristics

| Symbol | Description | Pre-adder | Multiplier | Post-adder | Speed Grade | | | | Units |
|---|---|-----------|------------|------------|----------------|----------------|----------------|-----------------|-------|
| | | | | | -3 | -3N | -2 | -1L | |
| Setup and Hold Times of Data/Control Pins to the Input Register Clock | | | | | | | | | |
| $T_{DSPDCK_A_A1REG}/$ $T_{DSPCKD_A_A1REG}$ | A input to A1 register CLK | N/A | N/A | N/A | 0.15/ 0.09 | 0.17/ 0.09 | 0.17/ 0.09 | 0.32/ 0.09 | ns |
| $T_{DSPDCK_D_B1REG}/$ $T_{DSPCKD_D_B1REG}$ | D input to B1 register CLK | Yes | N/A | N/A | 1.90/ -0.07 | 1.95/ -0.07 | 1.95/ -0.07 | 2.82/ -0.07 | ns |
| $T_{DSPDCK_C_CREG}/$ $T_{DSPCKD_C_CREG}$ | C input to C register CLK for XC devices | N/A | N/A | N/A | 0.11/ 0.15 | 0.13/ 0.15 | 0.13/ 0.15 | 0.24/ 0.09 | ns |
| | C input to C register CLK for XA and XQ devices | | | | 0.11/ 0.19 | N/A | 0.13/ 0.23 | 0.24/ 0.09 | |
| $T_{DSPDCK_D_DREG}/$ $T_{DSPCKD_D_DREG}$ | D input to D register CLK for XC devices | N/A | N/A | N/A | 0.09/ 0.15 | 0.10/ 0.15 | 0.10/ 0.15 | 0.19/ 0.12 | ns |
| | D input to D register CLK for XA and XQ devices | | | | 0.09/ 0.23 | N/A | 0.10/ 0.27 | 0.19/ 0.12 | |
| $T_{DSPDCK_OPMODE_B1REG}/$ $T_{DSPCKD_OPMODE_B1REG}$ | OPMODE input to B1 register CLK | Yes | N/A | N/A | 1.97/ 0.01 | 2.00/ 0.01 | 2.00/ 0.01 | 2.85/ 0.01 | ns |
| $T_{DSPDCK_OPMODE_OPMODEREG}/$ $T_{DSPCKD_OPMODE_OPMODEREG}$ | OPMODE input to OPMODE register CLK for XC devices | N/A | N/A | N/A | 0.18/ 0.12 | 0.21/ 0.12 | 0.21/ 0.12 | 0.40/ 0.12 | ns |
| | OPMODE input to OPMODE register CLK for XA and XQ devices | | | | 0.18/ 0.16 | N/A | 0.21/ 0.22 | 0.40/ 0.12 | |
| Setup and Hold Times of Data Pins to the Pipeline Register Clock | | | | | | | | | |
| $T_{DSPDCK_A_MREG}/$ $T_{DSPCKD_A_MREG}$ | A input to M register CLK | N/A | Yes | N/A | 3.06/ -0.40 | 3.51/ -0.40 | 3.51/ -0.40 | 3.97/ -0.40 | ns |
| $T_{DSPDCK_B_MREG}/$ $T_{DSPCKD_B_MREG}$ | B input to M register CLK | Yes | Yes | N/A | 3.96/ -0.68 | 4.58/ -0.68 | 4.58/ -0.68 | 7.00/ -0.68 | ns |
| $T_{DSPDCK_D_MREG}/$ $T_{DSPCKD_D_MREG}$ | D input to M register CLK | Yes | Yes | N/A | 4.23/ -0.56 | 4.80/ -0.56 | 4.80/ -0.56 | 6.84/ -0.56 | ns |
| $T_{DSPDCK_OPMODE_MREG}/$ $T_{DSPCKD_OPMODE_MREG}$ | OPMODE to M register CLK | Yes | Yes | N/A | 4.18/ -0.48 | 4.80/ -0.48 | 4.80/ -0.48 | 6.88/ -0.48 | ns |
| | | No | Yes | N/A | 2.37/ -0.48 | 2.70/ -0.48 | 2.70/ -0.48 | 4.28/ -0.48 | ns |
| Setup and Hold Times of Data/Control Pins to the Output Register Clock | | | | | | | | | |
| $T_{DSPDCK_A_PREG}/$ $T_{DSPCKD_A_PREG}$ | A input to P register CLK | N/A | Yes | Yes | 4.32/ -0.76 | 5.06/ -0.76 | 5.06/ -0.76 | 7.52/ -0.76 | ns |
| $T_{DSPDCK_B_PREG}/$ $T_{DSPCKD_B_PREG}$ | B input to P register CLK | Yes | Yes | Yes | 5.87/ -0.59 | 6.87/ -0.59 | 6.87/ -0.59 | 10.55/ -0.59 | ns |
| | | No | Yes | Yes | 4.14/ -0.93 | 4.68/ -0.93 | 4.68/ -0.93 | 8.12/ -0.93 | ns |
| $T_{DSPDCK_C_PREG}/$ $T_{DSPCKD_C_PREG}$ | C input to P register CLK | N/A | N/A | Yes | 2.20/ -0.23 | 2.25/ -0.23 | 2.25/ -0.23 | 3.27/ -0.23 | ns |
| $T_{DSPDCK_D_PREG}/$ $T_{DSPCKD_D_PREG}$ | D input to P register CLK | Yes | Yes | Yes | 5.90/ -0.92 | 6.91/ -0.92 | 6.91/ -0.92 | 10.39/ -0.92 | ns |

Configuration Switching Characteristics

Table 47: Configuration Switching Characteristics⁽¹⁾

| Symbol | Description | Speed Grade | | | | Units |
|---|---|-------------|----------|----------|----------|-------------|
| | | -3 | -3N | -2 | -1L | |
| Power-up Timing Characteristics | | | | | | |
| T _{PL} ⁽²⁾ | PROGRAM_B Latency | 4 | 4 | 4 | 5 | ms, Max |
| T _{POR} ⁽²⁾ | Power-on reset (50 ms ramp time) ⁽³⁾ | 5/30 | 5/34 | 5/40 | 5/40 | ms, Min/Max |
| | Power-on reset (10 ms ramp time) | 5/25 | 5/29 | 5/35 | 5/40 | ms, Min/Max |
| T _{PROGRAM} | PROGRAM_B Pulse Width | 500 | 500 | 500 | 500 | ns, Min |
| Slave Serial Mode Programming Switching | | | | | | |
| T _{DCCK} /T _{CCKD} | DIN Setup/Hold, slave mode | 6.0/1.0 | 6.0/1.0 | 6.0/1.0 | 8.0/2.0 | ns, Min |
| T _{CCO} | CCLK to DOUT | 12 | 12 | 12 | 17 | ns, Max |
| F _{SCCK} | Slave mode external CCLK | 80 | 80 | 80 | 50 | MHz, Max |
| Slave SelectMAP Mode Programming Switching | | | | | | |
| T _{SMDCCK} /T _{SMCCKD} | SelectMAP Data Setup/Hold | 6.0/1.0 | 6.0/1.0 | 6.0/1.0 | 8.0/2.0 | ns, Min |
| T _{SMCSCCK} /T _{SMCCKCS} | CSI_B Setup/Hold | 7.0/0.0 | 7.0/0.0 | 7.0/0.0 | 9.0/2.0 | ns, Min |
| T _{SMWCCK} /T _{SMCCKW} | RDWR_B Setup/Hold | 17.0/1.0 | 17.0/1.0 | 17.0/1.0 | 27.0/2.0 | ns, Min |
| T _{SMCKCSO} | CSO_B clock to out | 16 | 16 | 16 | 26 | ns, Max |
| T _{SMCO} | CCLK to DATA out in readback | 13 | 13 | 13 | 25 | ns, Max |
| T _{SMCKBY} | CCLK to BUSY out in readback | 12 | 12 | 12 | 17 | ns, Max |
| F _{SMCCK} | Maximum CCLK frequency (LX4, LX9, LX16, LX25, LX25T, LX45, LX45T, LX75, and LX75T only) | 50 | 50 | 50 | 25 | MHz, Max |
| | Maximum CCLK frequency (LX100 and LX100T in x8 mode, LX150, and LX150T only) | 40 | 40 | 40 | 20 | MHz, Max |
| | Maximum CCLK frequency (LX100 and LX100T in x16 mode only) | 35 | 35 | 35 | 20 | MHz, Max |
| F _{RBCK} | Maximum Readback CCLK frequency, including block RAM (LX4, LX9, LX16, LX25, LX25T, LX45, LX45T, LX75, and LX75T only) | 20 | 20 | 20 | 4 | MHz, Max |
| | Maximum Readback CCLK frequency, ignoring block RAM (POST_CRC) (LX4, LX9, LX16, LX25, LX25T, LX45, LX45T, LX75, and LX75T only) | 50 | 50 | 50 | 30 | MHz, Max |
| | Maximum Readback CCLK frequency, including block RAM (LX100, LX100T, LX150, and LX150T only) | 12 | 12 | 12 | 4 | MHz, Max |
| | Maximum Readback CCLK frequency, ignoring block RAM (POST_CRC) (LX100, LX100T, LX150, and LX150T only) | 35 | 35 | 35 | 20 | MHz, Max |
| Boundary-Scan Port Timing Specifications | | | | | | |
| T _{TAPTCK} | TMS and TDI Setup time before TCK | 10 | 10 | 10 | 17 | ns, Min |
| T _{TCKTAP} | TMS and TDI Hold time after TCK | 5.5 | 5.5 | 5.5 | 5.5 | ns, Min |
| T _{TCKTDO} | TCK falling edge to TDO output valid | 6.5 | 6.5 | 6.5 | 8 | ns, Max |
| T _{TCKH} | TCK clock minimum High time | 12 | 12 | 12 | 21 | ns, Min |
| T _{TCKL} | TCK clock minimum Low time | 12 | 12 | 12 | 21 | ns, Min |
| F _{TCK} | Maximum configuration TCK clock frequency | 33 | 33 | 33 | 18 | MHz, Max |
| F _{TCKB} | Maximum boundary-scan TCK clock frequency | 33 | 33 | 33 | 18 | MHz, Max |
| F _{TCKAES} | Maximum AES key TCK clock frequency | 2 | 2 | 2 | 2 | MHz, Max |

Table 57: Switching Characteristics for the Digital Frequency Synthesizer DFS (DCM_CLKGEN)⁽¹⁾

| Symbol | Description | Speed Grade | | | | | | | | Units |
|---|--|--|-------|---------|-------|---------|-------|---------|-----|-------|
| | | -3 | | -3N | | -2 | | -1L | | |
| | | Min | Max | Min | Max | Min | Max | Min | Max | |
| Output Frequency Ranges (DCM_CLKGEN) | | | | | | | | | | |
| CLKOUT_FREQ_FX | Frequency for the CLKFX and CLKFX180 outputs | 5 | 375 | 5 | 375 | 5 | 333 | 5 | 200 | MHz |
| CLKOUT_FREQ_FXDV | Frequency for the CLKFXDV output | 0.15625 | 187.5 | 0.15625 | 187.5 | 0.15625 | 166.5 | 0.15625 | 100 | MHz |
| Output Clock Jitter⁽²⁾⁽³⁾ | | | | | | | | | | |
| CLKOUT_PER_JITT_FX | Period jitter at the CLKFX and CLKFX180 outputs. | Typical = $\pm[0.2\%$ of CLKFX period + 100] | | | | | | | | ps |
| CLKOUT_PER_JITT_FXDV | Period jitter at the CLKFXDV output. | Typical = $\pm[0.2\%$ of CLKFX period + 100] | | | | | | | | ps |
| CLKFX_FREEZE_VAR | CLKFX period change in free running oscillator mode at the same temperature. FCLKFX > 50 MHz | Maximum = $\pm 3\%$ of CLKFX period | | | | | | | | ps |
| | CLKFX period change in free running oscillator mode at the same temperature. FCLKFX < 50 MHz | Maximum = $\pm 5\%$ of CLKFX period | | | | | | | | ps |
| CLKFX_FREEZE_TEMP_SLOPE | CLKFX period will change in free_oscillator mode over temperature. Add to CLKFX_FREEZE_VAR to determine total CLKFX period change. Percentage change for CLKFX period over 1°C. | Maximum = 0.1 | | | | | | | | %/°C |
| Duty Cycle⁽⁴⁾⁽⁵⁾ | | | | | | | | | | |
| CLKOUT_DUTY_CYCLE_FX | Duty cycle precision for the CLKFX and CLKFX180 outputs, including the BUFGMUX and clock tree duty-cycle distortion | Maximum = $\pm[1\%$ of CLKFX period + 350] | | | | | | | | ps |
| CLKOUT_DUTY_CYCLE_FXDV | Duty cycle precision for the CLKFXDV outputs, including the BUFGMUX and clock tree duty-cycle distortion | Maximum = $\pm[1\%$ of CLKFX period + 350] | | | | | | | | ps |
| Lock Time | | | | | | | | | | |
| LOCK_FX ⁽²⁾ | The time from deassertion at the DCM's Reset input to the rising transition at its LOCKED output. The DFS asserts LOCKED when the CLKFX, CLKFX180, and CLKFXDV signals are valid. Lock time requires CLKFX_DIVIDE < F _{IN} /(0.50 MHz) when: F _{CLKIN} < 50 MHz | – | 50 | – | 50 | – | 50 | – | 50 | ms |
| | when: F _{CLKIN} > 50 MHz | – | 5 | – | 5 | – | 5 | – | 5 | ms |

Table 57: Switching Characteristics for the Digital Frequency Synthesizer DFS (DCM_CLKGEN)⁽¹⁾ (Cont'd)

| Symbol | Description | Speed Grade | | | | | | | | Units |
|---|--|---|-----|-----|-----|-----|-----|-----|-----|-------|
| | | -3 | | -3N | | -2 | | -1L | | |
| | | Min | Max | Min | Max | Min | Max | Min | Max | |
| Spread Spectrum | | | | | | | | | | |
| F _{CLKIN_FIXED_SPREAD_SPECTRUM} | Frequency of the CLKIN input for fixed spread spectrum (SPREAD_SPECTRUM = CENTER_LOW_SPREAD/ CENTER_HIGH_SPREAD) | 30 | 200 | 30 | 200 | 30 | 200 | 30 | 200 | MHz |
| T _{CENTER_LOW_SPREAD} ⁽⁶⁾ | Spread at the CLKFX output for fixed spread spectrum (SPREAD_SPECTRUM = CENTER_LOW_SPREAD) | Typical = $\frac{100}{\text{CLKFX_DIVIDE}}$ Maximum = 250 | | | | | | | | ps |
| T _{CENTER_HIGH_SPREAD} ⁽⁶⁾ | Spread at the CLKFX output for fixed spread spectrum (SPREAD_SPECTRUM = CENTER_HIGH_SPREAD) | Typical = $\frac{240}{\text{CLKFX_DIVIDE}}$ Maximum = 400 | | | | | | | | ps |
| F _{MOD_FIXED_SPREAD_SPECTRUM} ⁽⁶⁾ | Average modulation frequency when using fixed spread spectrum (SPREAD_SPECTRUM = CENTER_LOW_SPREAD / CENTER_HIGH_SPREAD) | Typical = F _{IN} /1024 | | | | | | | | MHz |

Notes:

1. The values in this table are based on the operating conditions described in Table 2 and Table 55.
2. For optimal jitter tolerance and a faster LOCK time, use the CLKIN_PERIOD attribute.
3. Output jitter is characterized with no input jitter. Output jitter strongly depends on the environment, including the number of SSOs, the output drive strength, CLB utilization, CLB switching activities, switching frequency, power supply, and PCB design. The actual maximum output jitter depends on the system application.
4. The CLKFX, CLKFXDV, and CLKFX180 outputs have a duty cycle of approximately 50%.
5. Some duty-cycle and alignment specifications include a percentage of the CLKFX output period. For example, this data sheet specifies a maximum CLKFX jitter of ±(1% of CLKFX period + 200 ps). Assuming that the CLKFX output frequency is 100 MHz, the equivalent CLKFX period is 10 ns, and 1% of 10 ns is 0.1 ns or 100 ps. Accordingly, the maximum jitter is ±(100 ps + 200 ps) = ±300 ps.
6. When using CENTER_LOW_SPREAD, CENTER_HIGH_SPREAD, the valid values for CLKFX_MULTIPLY are limited to 2 through 32, and the valid values for CLKFX_DIVIDE are limited to 1 through 4.

Table 58: Recommended Operating Conditions for the Phase-Shift Clock in Variable Phase Mode (DCM_SP) or Dynamic Frequency Synthesis (DCM_CLKGEN)

| Symbol | Description | Speed Grade | | | | | | | | Units |
|-----------------------------------|---|-------------|-----|-----|-----|-----|-----|-----|-----|-------|
| | | -3 | | -3N | | -2 | | -1L | | |
| | | Min | Max | Min | Max | Min | Max | Min | Max | |
| Operating Frequency Ranges | | | | | | | | | | |
| PSCLK_FREQ | Frequency for the PSCLK (DCM_SP) or PROGCLK (DCM_CLKGEN) input. | 1 | 167 | 1 | 167 | 1 | 167 | 1 | 100 | MHz |
| Input Pulse Requirements | | | | | | | | | | |
| PSCLK_PULSE | PSCLK (DCM_SP) or PROGCLK (DCM_CLKGEN) pulse width as a percentage of the clock period. | 40 | 60 | 40 | 60 | 40 | 60 | 40 | 60 | % |

Table 65: Global Clock Input to Output Delay With DCM in Source-Synchronous Mode

| Symbol | Description | Device | Speed Grade | | | | Units |
|---|--|------------|-------------|------|------|------|-------|
| | | | -3 | -3N | -2 | -1L | |
| LVCMOS25 Global Clock Input to Output Delay using Output Flip-Flop, 12mA, Fast Slew Rate, <i>with</i> DCM in Source-Synchronous Mode. | | | | | | | |
| T _{ICKOFDCM_0} | Global Clock and OUTFF <i>with</i> DCM | XC6SLX4 | 5.03 | N/A | 7.21 | 8.05 | ns |
| | | XC6SLX9 | 5.03 | 6.13 | 7.21 | 8.05 | ns |
| | | XC6SLX16 | 5.08 | 5.51 | 6.44 | 7.96 | ns |
| | | XC6SLX25 | 4.81 | 5.13 | 5.69 | 7.94 | ns |
| | | XC6SLX25T | 4.81 | 5.13 | 5.69 | N/A | ns |
| | | XC6SLX45 | 5.26 | 5.69 | 6.63 | 7.92 | ns |
| | | XC6SLX45T | 5.26 | 5.69 | 6.63 | N/A | ns |
| | | XC6SLX75 | 4.77 | 5.18 | 5.88 | 7.95 | ns |
| | | XC6SLX75T | 4.77 | 5.18 | 5.88 | N/A | ns |
| | | XC6SLX100 | 4.72 | 5.11 | 5.76 | 8.59 | ns |
| | | XC6SLX100T | 4.76 | 5.11 | 5.76 | N/A | ns |
| | | XC6SLX150 | 4.90 | 5.30 | 5.93 | 7.93 | ns |
| | | XC6SLX150T | 4.90 | 5.30 | 5.93 | N/A | ns |
| | | XA6SLX4 | 5.35 | N/A | 7.21 | N/A | ns |
| | | XA6SLX9 | 5.35 | N/A | 7.21 | N/A | ns |
| | | XA6SLX16 | 5.42 | N/A | 6.44 | N/A | ns |
| | | XA6SLX25 | 5.13 | N/A | 5.69 | N/A | ns |
| | | XA6SLX25T | 5.13 | N/A | 5.79 | N/A | ns |
| | | XA6SLX45 | 5.58 | N/A | 6.63 | N/A | ns |
| | | XA6SLX45T | 5.58 | N/A | 6.63 | N/A | ns |
| | | XA6SLX75 | 5.09 | N/A | 5.87 | N/A | ns |
| | | XA6SLX75T | 5.09 | N/A | 5.87 | N/A | ns |
| | | XA6SLX100 | N/A | N/A | 6.44 | N/A | ns |
| | | XQ6SLX75 | N/A | N/A | 5.87 | 7.95 | ns |
| | | XQ6SLX75T | 5.09 | N/A | 5.87 | N/A | ns |
| | | XQ6SLX150 | N/A | N/A | 6.06 | 7.93 | ns |
| XQ6SLX150T | 5.50 | N/A | 6.06 | N/A | ns | | |

Notes:

1. Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.
2. DCM output jitter is already included in the timing calculation.

Table 73: Global Clock Setup and Hold With DCM in Source-Synchronous Mode

| Symbol | Description | Device | Speed Grade | | | | Units |
|--|--|------------|-------------|-----------|-----------|-----------|-------|
| | | | -3 | -3N | -2 | -1L | |
| Input Setup and Hold Time Relative to Global Clock Input Signal for LVC MOS25 Standard.⁽¹⁾ | | | | | | | |
| T _{PSDCMO} / T _{PHDCMO} | No Delay Global Clock and IFF ⁽²⁾ with DCM in Source-Synchronous Mode | XC6SLX4 | 0.71/0.65 | N/A | 0.72/1.22 | 1.58/1.18 | ns |
| | | XC6SLX9 | 0.71/0.69 | 0.71/1.19 | 0.72/1.36 | 1.58/1.18 | ns |
| | | XC6SLX16 | 0.86/0.52 | 0.92/0.57 | 1.04/0.60 | 1.02/1.06 | ns |
| | | XC6SLX25 | 0.84/0.58 | 0.90/0.59 | 1.01/0.59 | 1.58/1.07 | ns |
| | | XC6SLX25T | 0.84/0.58 | 0.90/0.59 | 1.01/0.59 | N/A | ns |
| | | XC6SLX45 | 0.85/0.70 | 0.90/0.76 | 0.98/0.79 | 1.34/1.34 | ns |
| | | XC6SLX45T | 0.85/0.70 | 0.90/0.76 | 0.98/0.79 | N/A | ns |
| | | XC6SLX75 | 1.00/0.62 | 1.06/0.63 | 1.15/0.63 | 1.65/1.46 | ns |
| | | XC6SLX75T | 1.00/0.71 | 1.06/0.72 | 1.15/0.72 | N/A | ns |
| | | XC6SLX100 | 0.81/0.68 | 0.81/0.69 | 0.94/0.69 | 1.42/2.07 | ns |
| | | XC6SLX100T | 0.81/0.68 | 0.81/0.69 | 0.94/0.69 | N/A | ns |
| | | XC6SLX150 | 0.68/0.98 | 0.69/0.99 | 0.79/0.99 | 1.45/1.60 | ns |
| | | XC6SLX150T | 0.68/0.98 | 0.69/0.99 | 0.79/0.99 | N/A | ns |
| | | XA6SLX4 | 0.81/0.74 | N/A | 0.72/1.36 | N/A | ns |
| | | XA6SLX9 | 0.81/0.74 | N/A | 0.72/1.36 | N/A | ns |
| | | XA6SLX16 | 1.01/0.56 | N/A | 1.04/0.60 | N/A | ns |
| | | XA6SLX25 | 0.94/0.76 | N/A | 1.06/0.77 | N/A | ns |
| | | XA6SLX25T | 0.94/0.76 | N/A | 1.14/0.77 | N/A | ns |
| | | XA6SLX45 | 0.86/0.74 | N/A | 0.98/0.78 | N/A | ns |
| | | XA6SLX45T | 0.86/0.74 | N/A | 0.98/0.78 | N/A | ns |
| | | XA6SLX75 | 1.02/0.71 | N/A | 1.15/0.72 | N/A | ns |
| | | XA6SLX75T | 1.02/0.71 | N/A | 1.15/0.72 | N/A | ns |
| | | XA6SLX100 | N/A | N/A | 1.37/0.75 | N/A | ns |
| | | XQ6SLX75 | N/A | N/A | 1.15/0.72 | 1.65/1.46 | ns |
| | | XQ6SLX75T | 1.02/0.71 | N/A | 1.15/0.72 | N/A | ns |
| | | XQ6SLX150 | N/A | N/A | 0.79/1.15 | 1.45/1.60 | ns |
| XQ6SLX150T | 0.73/1.15 | N/A | 0.79/1.15 | N/A | ns | | |

Notes:

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage. These measurements include DCM CLK0 jitter.
2. IFF = Input Flip-Flop or Latch
3. Use IBIS to determine any duty-cycle distortion incurred using various standards.

Table 74: Global Clock Setup and Hold With PLL in System-Synchronous Mode

| Symbol | Description | Device | Speed Grade | | | | Units |
|--|--|------------|-------------|------------|------------|-----------|-------|
| | | | -3 | -3N | -2 | -1L | |
| Input Setup and Hold Time Relative to Global Clock Input Signal for LVC MOS25 Standard.⁽¹⁾ | | | | | | | |
| T _{PSPLL} / T _{PHPLL} | No Delay Global Clock and IFF ⁽²⁾ with PLL in System-Synchronous Mode | XC6SLX4 | 1.37/0.25 | N/A | 1.52/0.41 | 2.07/0.69 | ns |
| | | XC6SLX9 | 1.37/0.21 | 1.48/0.21 | 1.52/0.26 | 2.07/0.69 | ns |
| | | XC6SLX16 | 1.33/-0.03 | 1.53/-0.02 | 1.60/-0.02 | 1.57/0.48 | ns |
| | | XC6SLX25 | 1.65/0.28 | 1.71/0.28 | 1.91/0.28 | 2.44/0.76 | ns |
| | | XC6SLX25T | 1.65/0.28 | 1.71/0.28 | 1.91/0.28 | N/A | ns |
| | | XC6SLX45 | 1.55/0.18 | 1.64/0.18 | 1.75/0.18 | 2.02/0.90 | ns |
| | | XC6SLX45T | 1.55/0.18 | 1.64/0.18 | 1.75/0.18 | N/A | ns |
| | | XC6SLX75 | 1.77/0.21 | 1.89/0.21 | 2.13/0.21 | 2.46/0.53 | ns |
| | | XC6SLX75T | 1.77/0.21 | 1.89/0.21 | 2.13/0.21 | N/A | ns |
| | | XC6SLX100 | 1.44/0.32 | 1.52/0.32 | 1.70/0.32 | 1.78/0.86 | ns |
| | | XC6SLX100T | 1.44/0.32 | 1.52/0.32 | 1.70/0.32 | N/A | ns |
| | | XC6SLX150 | 1.39/0.49 | 1.48/0.49 | 1.67/0.49 | 1.94/0.94 | ns |
| | | XC6SLX150T | 1.39/0.49 | 1.48/0.49 | 1.67/0.49 | N/A | ns |
| | | XA6SLX4 | 1.61/0.10 | N/A | 1.64/0.28 | N/A | ns |
| | | XA6SLX9 | 1.61/0.10 | N/A | 1.64/0.28 | N/A | ns |
| | | XA6SLX16 | 1.89/-0.08 | N/A | 1.72/-0.08 | N/A | ns |
| | | XA6SLX25 | 1.85/0.16 | N/A | 2.08/0.16 | N/A | ns |
| | | XA6SLX25T | 1.85/0.16 | N/A | 2.17/0.16 | N/A | ns |
| | | XA6SLX45 | 1.58/0.07 | N/A | 1.87/0.03 | N/A | ns |
| | | XA6SLX45T | 1.58/0.07 | N/A | 1.87/0.03 | N/A | ns |
| | | XA6SLX75 | 1.80/0.06 | N/A | 2.25/0.06 | N/A | ns |
| | | XA6SLX75T | 1.80/0.06 | N/A | 2.25/0.06 | N/A | ns |
| | | XA6SLX100 | N/A | N/A | 2.34/0.14 | N/A | ns |
| | | XQ6SLX75 | N/A | N/A | 2.25/0.06 | 2.46/0.53 | ns |
| XQ6SLX75T | 1.80/0.06 | N/A | 2.25/0.06 | N/A | ns | | |
| XQ6SLX150 | N/A | N/A | 1.79/0.37 | 1.94/0.94 | ns | | |
| XQ6SLX150T | 1.43/0.37 | N/A | 1.79/0.37 | N/A | ns | | |

Notes:

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage. These measurements include PLL CLKOUT0 jitter.
2. IFF = Input Flip-Flop or Latch
3. Use IBIS to determine any duty-cycle distortion incurred using various standards.

| Date | Version | Description of Revisions |
|----------|---------|---|
| 01/10/11 | 1.11 | <p>Production release of XC6SLX4 and XC6SLX9 in the specific speed grades listed in Table 26 and Table 27 using ISE v12.4 software with speed specification v1.15 for the -4, -3, -3N, and -2 speed grades. Added note 3 to Table 27. Also updated the -1L speed grade requirements to ISE v12.4 software with speed specification v1.06. Revised -3N definition throughout the document.</p> <p>Added note 4 to Table 2 and updated note 5. Added information on V_{CCINT} to note 1 in Table 5. Updated Networking Applications -3 values in Table 25 to match improvements made in ISE v12.4. In Table 28, added note 1 and revised the T_{IOTP} values for LVDS_33, LVDS_25, MINI_LVDS_33, MINI_LVDS_25, RSDS_33, RSDS_25, TMDS_33, PPDS_33, and PPDS_25. Added note 3 to Table 55.</p> |
| 02/11/11 | 1.12 | <p>As described in XCN11008: Product Discontinuation Notice For Spartan-6 LXT -4 Devices, the -4 speed specifications have been discontinued. As outlined in page 2 of the XCN, designers currently using -4 speed specifications should rerun timing analysis using the new -3 speed specifications before moving to a replacement device.</p> <p>Updated the networking applications section of Table 25. Updated -2 speed specifications throughout document and added note 3 to Table 27 advising designers to use the -2 speed specification update (v1.17) with the ISE 12.4 software patch. Added F_{CLKDIV} to Table 37 and Table 38. Updated note 2 in Table 39. Updated units for $T_{SMCKCSO}$ and T_{BPICCO} in Table 47. Updated -1L in Table 71. Removed Note 2: <i>Package delay information is available for these device/package combinations. This information can be used to deskew the package</i> from Table 79.</p> |
| 03/31/11 | 2.0 | <p>Production release of XC6SLX45 in the -1L speed grades listed in Table 26 and Table 27 using ISE v13.1 software with -1L speed specification v1.06.</p> <p>In Table 39, removed values in the -1L column and added note 3 as IODELAY2 only supports Tap0 for lower-power devices. Updated copyright page 1 and Notice of Disclaimer.</p> |
| 05/20/11 | 2.1 | <p>Production release of XC6SLX100 and XC6SLX150 in the specific speed grades listed in Table 26 and Table 27 using ISE v13.1 software with -1L speed specification v1.06. Updated Table 27 and Note 7 with changes per XCN11012: Speed File Change for -3N Devices. Revised Switching Characteristics section for speed specifications: v1.18 for -3, -3N, and -2; including improvements in Table 73 through Table 77 and Table 81.</p> <p>Removed <i>Memory Controller Block</i> from the performance heading in Table 2 and revised Note 2. In Table 4, added Note 1 to C_{IN} and updated the description of R_{IN_TERM}. Updated Note 1 in Table 5. Updated Note 1 of Table 7. In Table 25, added and removed -1L specifications, increased the standard performance DDR3 specifications, removed the extended performance DDR3 row and updated Note 3 and Note 4. Clarified the introductory information for Table 28 and Table 30.</p> <p>In Table 32: Revised V_{MEAS} value for LVCMOS12; revised V_{REF} for LVDS_25, LVDS_33, BLVDS_25, MINI_LVDS_25, MINI_LVDS_33, RSDS_25, and RSDS_33; revised R_{REF} for BLVDS_25 and TMDS_33; and added Note 4 and Note 5. Updated Note 2 and Note 3 in Table 39.</p> <p>In Table 47, revised the values and description of T_{POR} including adding Note 3. Also in Table 47, augmented the description and added specifications for F_{RBCK} and removed XC6SLX4 from F_{MCCK} (maximum frequency, parallel mode (Master SelectMAP/BPI)). Added BUFGMUX to Table 48 title. Added Table 50.</p> <p>In Table 52, revised specifications for $T_{EXTFVAR}$ and $F_{INJITTER}$. In Table 54 removed the 5 MHz < $CLKIN_FREQ_DLL$ parameter in the LOCK_DLL description. In both Table 56 and Table 57, removed the 5 MHz < F_{CLKIN} parameter in the LOCK_FX description. In Table 58, updated description for PSCLK_FREQ and PSCLK_PULSE.</p> <p>Revised title and symbol of Table 70, added new speed specifications for -1L, and added Note 2. Added Table 71.</p> |
| 07/11/11 | 2.2 | <p>Added the Automotive XA Spartan-6 and Defense-grade Spartan-6Q devices to all appropriate tables while sometimes removing the XC6S nomenclature. Added expanded temperature range (Q) to all appropriate tables. Updated T_{SOL} packages in Table 1. Added R_{OUT_TERM} to Table 4. Updated Note 2 on Table 13.</p> <p>Production release of the XC6SLX4, XC6SLX9, XC6SLX16, XC6SLX25, XC6SLX75, XQ6SLX75, and XQ6SLX150 in Table 26 and Table 27 using ISE v13.2 software with -1L speed specification v1.07.</p> <p>Production release of the XA6SLX16, XA6SLX25T, XA6SLX45, XA6SLX45T, XQ6SLX75, XQ6SLX75T, XQ6SLX150, and XQ6SLX150T in Table 26 and Table 27 using ISE v13.2 software with -2 and -3 speed specification v1.19.</p> <p>Added Table 29: IOB Switching Characteristics for the Automotive XA Spartan-6 and the Spartan-6Q Devices(1). Updated CS(G)484 from CSG484 throughout data sheet. Clarified Note 3 in Table 39.</p> |
| 08/08/11 | 2.3 | <p>Production release of the XA6SLX25, XA6SLX75, and XA6SLX75T in Table 26 and Table 27 using ISE v13.2 software with -2 and -3 speed specification v1.19.</p> |